Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/724,938	CHENG ET AL.
Examiner	**Art Unit**
Nathan W. Ha	2814

SEARCHED

Class	Subclass	Date	Examiner
438	612-613	5/28/07	NH
257	779		
	734-738		
	E23.04		

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner
See printouts		5/28/07	NH

SEARCH NOTES (INCLUDING SEARCH STRATEGY)

	DATE	EXMR
See printouts	5/28/07	NH